

## MTP10N10-VB Datasheet N-Channel 100-V (D-S) MOSFET

| PRODUCT                  | SUMMARY                        |                    |
|--------------------------|--------------------------------|--------------------|
| V <sub>(BR)DSS</sub> (V) | R <sub>DS(on)</sub> (Ω)        | I <sub>D</sub> (A) |
| 100                      | 0.127at V <sub>GS</sub> = 10 V | 18                 |

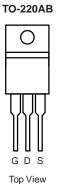
#### FEATURES

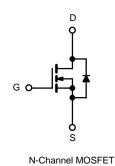
- TrenchFET<sup>®</sup> Power MOSFET
- 175 °C Junction Temperature
- Low Thermal Resistance Package
- 100 % R<sub>g</sub> Tested

#### **APPLICATIONS**

• Isolated DC/DC Converters







| ABSOLUTE MAXIMUM RATINGS Parameter                  | $10 - 20^{\circ}$ 0, unloss our     | Symbol                            | Limit       | Unit |  |
|---|-------------------------------------|-----------------------------------|-------------|------|--|
|   |                                     | -                                 |             | Unit |  |
| Drain-Source Voltage                                |                                     | V <sub>DS</sub>                   | 100         | v    |  |
| Gate-Source Voltage                                 |                                     | V <sub>GS</sub>                   | ± 20        |      |  |
| Continuous Drain Current ( $T_1 = 175 \text{ °C}$ ) | T <sub>C</sub> = 25 °C              | I <sub>D</sub>                    | 18          |      |  |
| Continuous Drain Current (1j = 175°C)               | T <sub>C</sub> = 125 °C             | di                                | 15          | A    |  |
| Pulsed Drain Current                                |                                     | I <sub>DM</sub>                   | 68          |      |  |
| Avalanche Current                                   | L = 0.1 mH                          | I <sub>AS</sub>                   | 18          |      |  |
| ingle Pulse Avalanche Energy <sup>b</sup>           |                                     | E <sub>AS</sub>                   | 200         | mJ   |  |
| Mauianum Daura Diasinationh                         | T <sub>C</sub> = 25 °C              |                                   | 105         | W    |  |
| Maximum Power Dissipation <sup>b</sup>              | T <sub>A</sub> = 25 °C <sup>d</sup> | F.D                               | 3.75        | vv   |  |
| Operating Junction and Storage Temperature Range    |                                     | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 175 | °C   |  |

| THERMAL RESISTANCE RA    | ATINGS                          |                   |       |      |
|--------------------------|---------------------------------|-------------------|-------|------|
| Parameter                |                                 | Symbol            | Limit | Unit |
| Junction-to-Ambient      | PCB Mount (TO-263) <sup>d</sup> | R <sub>thJA</sub> | 40    | °C/W |
| Junction-to-Case (Drain) |                                 | R <sub>thJC</sub> | 0.4   | 0,00 |

Notes:

a. Package limited.

b. Duty cycle  $\leq$  1 %.

c. See SOA curve for voltage derating.

d. When Mounted on 1" square PCB (FR-4 material).

| <b>SPECIFICATIONS</b> $T_J = 25^{\circ}$      | C, unless o          | therwise noted   |      |       |       |      |
|---|----------------------|--|------|-------|-------|------|
| Parameter                                     | Symbol               | Test Conditions  | Min. | Тур.  | Max.  | Unit |
| Static  |                      |  | •    |       |       |      |
| Drain-Source Breakdown Voltage                | V <sub>(BR)DSS</sub> | $V_{DS} = 0 V, I_{D} = 250 \mu A$  | 100  |       |       | V    |
| Gate-Threshold Voltage                        | V <sub>GS(th)</sub>  | $V_{DS} = V_{GS}, I_D = 250 \ \mu A$   | 2    |       | 4     | v    |
| Gate-Body Leakage                             | I <sub>GSS</sub>     | $V_{DS} = 0 V, V_{GS} = \pm 20 V$  |      |       | ± 100 | nA   |
|   |                      | $V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$                                 |      |       | 1     |      |
| Zero Gate Voltage Drain Current               | I <sub>DSS</sub>     | $V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 \text{ °C}$ |      |       | 50    | μA   |
|   |                      | V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 175 °C                |      |       | 250   |      |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>   | $V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$                                | 120  |       |       | А    |
|   |                      | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A  |      | 0.127 |       |      |
| Drain-Source On-State Resistance <sup>a</sup> | r <sub>DS(on)</sub>  | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 125 °C                 |      | 0.130 |       | Ω    |
|   |                      | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 175 °C                 |      | 0.170 |       |      |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>      | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A  | 25   |       |       | S    |
| Dynamic <sup>b</sup>                          | •                    |  |      | •     |       |      |
| Input Capacitance                             | C <sub>iss</sub>     |  |      | 1300  |       | pF   |
| Output Capacitance                            | C <sub>oss</sub>     | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1 MHz                               |      | 260   |       |      |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>     |  |      | 110   |       |      |
| Total Gate Charge <sup>c</sup>                | Qg                   |  |      |       | 28    |      |
| Gate-Source Charge <sup>c</sup>               | Q <sub>gs</sub>      | $V_{DS}$ = 100 V, $V_{GS}$ = 10 V, $I_{D}$ = 65 A                                      |      |       | 4.8   | nC   |
| Gate-Drain Charge <sup>c</sup>                | Q <sub>gd</sub>      |  |      |       | 15    |      |
| Gate Resistance                               | Rg                   |  | 0.5  | 1.7   | 3.3   | Ω    |
| Turn-On Delay Time <sup>c</sup>               | t <sub>d(on)</sub>   |  |      | 8     |       |      |
| Rise Time <sup>c</sup>                        | t <sub>r</sub>       | $V_{DD}$ = 100 V, R <sub>L</sub> = 1.5 $\Omega$  |      | 120   |       |      |
| Turn-Off Delay Time <sup>c</sup>              | t <sub>d(off)</sub>  | $\rm I_D \cong 65$ A, $\rm V_{GEN}$ = 10 V, $\rm R_g$ = 2.5 $\Omega$                   |      | 25    |       | ns   |
| Fall Time <sup>c</sup>                        | t <sub>f</sub>       |  |      | 50    |       |      |
| Source-Drain Diode Ratings and Ch             | aracteristics 7      | $\Gamma_{\rm C} = 25 \ {}^{\circ}{\rm C}^{\rm b}$                                      |      |       |       |      |
| Continuous Current                            | ا <sub>S</sub>       |  |      | 18    |       | •    |
| Pulsed Current                                | I <sub>SM</sub>      |  |      | 68    |       | A    |
| Forward Voltage <sup>a</sup>                  | V <sub>SD</sub>      | I <sub>F</sub> = 65 A, V <sub>GS</sub> = 0 V   |      | 1.0   | 1.5   | V    |
| Reverse Recovery Time                         | t <sub>rr</sub>      |  |      | 130   | 200   | ns   |
| Peak Reverse Recovery Current                 | I <sub>RM(REC)</sub> | I <sub>F</sub> = 50 A, di/dt = 100 A/μs  |      | 8     | 12    | А    |
| Reverse Recovery Charge                       | Q <sub>rr</sub>      |  |      | 0.52  | 1.2   | μC   |

Notes:

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

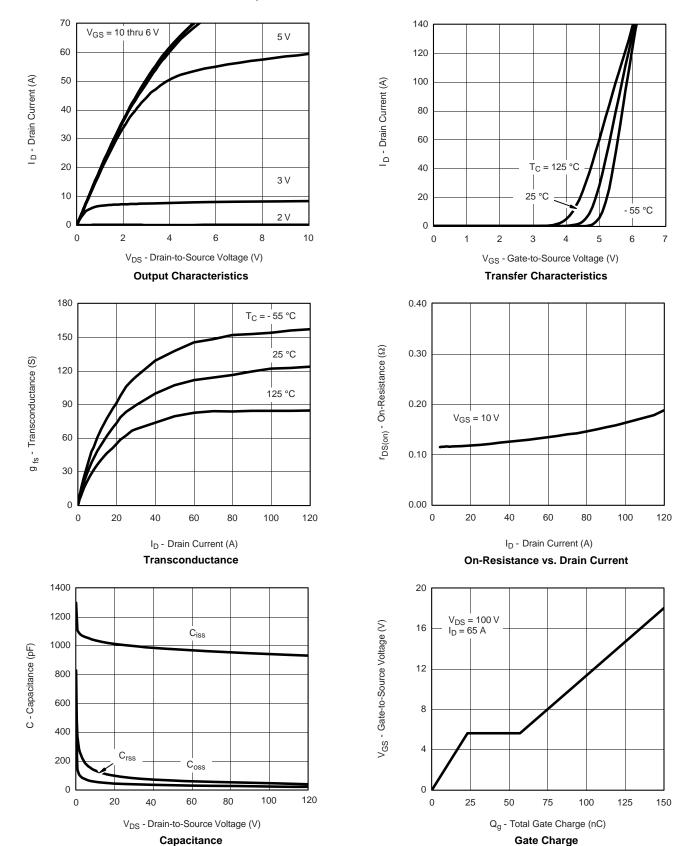
b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Bsemi

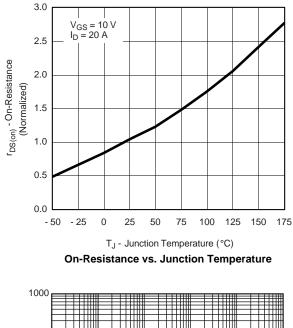


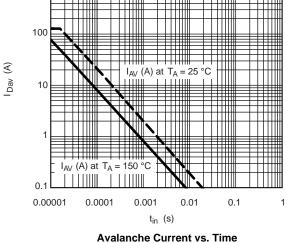


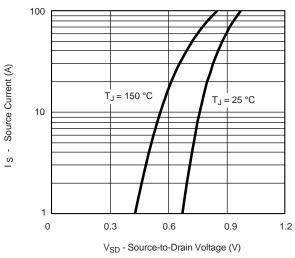
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



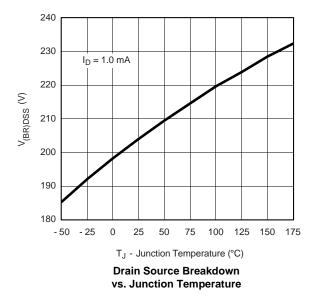
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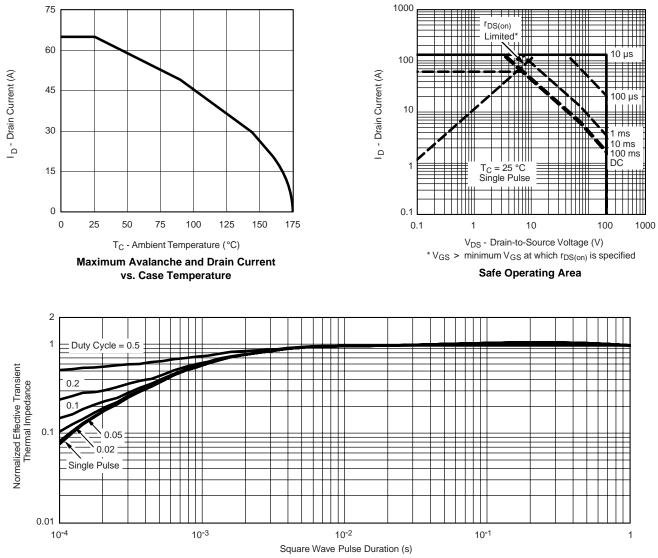
Source-Drain Diode Forward Voltage



## MTP10N10-VB

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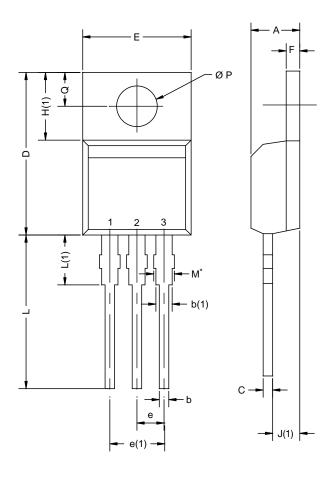
#### THERMAL RATINGS



Normalized Thermal Transient Impedance, Junction-to-Case



## **TO-220AB**



|                       | MILLIN            | IETERS    | INC   | HES   |
|-----------------------|-------------------|-----------|-------|-------|
| DIM.                  | MIN.              | MAX.      | MIN.  | MAX.  |
| А                     | 4.25              | 4.65      | 0.167 | 0.183 |
| b                     | 0.69              | 1.01      | 0.027 | 0.040 |
| b(1)                  | 1.20              | 1.73      | 0.047 | 0.068 |
| С                     | 0.36              | 0.61      | 0.014 | 0.024 |
| D                     | 14.85             | 15.49     | 0.585 | 0.610 |
| E                     | 10.04             | 10.51     | 0.395 | 0.414 |
| е                     | 2.41              | 2.67      | 0.095 | 0.105 |
| e(1)                  | 4.88              | 5.28      | 0.192 | 0.208 |
| F                     | 1.14              | 1.40      | 0.045 | 0.055 |
| H(1)                  | 6.09              | 6.48      | 0.240 | 0.255 |
| J(1)                  | 2.41              | 2.92      | 0.095 | 0.115 |
| L                     | 13.35             | 14.02     | 0.526 | 0.552 |
| L(1)                  | 3.32              | 3.82      | 0.131 | 0.150 |
| ØΡ                    | 3.54              | 3.94      | 0.139 | 0.155 |
| Q                     | 2.60              | 3.00      | 0.102 | 0.118 |
| ECN: X12-<br>DWG: 547 | 0208-Rev. N,<br>1 | 08-Oct-12 |       |       |

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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